



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Satoshi Murakami, et al.

Art Unit : 2814

Serial No.: 10/006,043

Examiner: Nathan W. Ha

Filed

: December 4, 2001

Title

: SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE

**SAME** 

## **MAIL STOP RCE**

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

Submitted herewith is an English translation of the following foreign language references, or portions thereof:

Desig. ID	Source
AL	JAPAN 2000-332256 – English Abstract: DIALOG(R)File 347: JAPIO
	(2005); Accession No. 06746401 and family to U.S. Patent No. 6,306,694
	(Desig. ID "AA"), U.S. Patent No. 6,737,304 (Desig. ID "AB"), U.S. Patent
	Application Publication No. 2002/0028543 (Desig. ID "AC") and U.S. Patent
	Application Publication No. 2004/0197971 (Desig. ID "AD").

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Date:

Customer No. 26171

Fish & Richardson P.C.

1425 K Street, N.W. - 11th Floor Washington, DC 20005-3500

Telephone: (202) 783-5070 Facsimile: (202) 783-2331

/adt 40294596.doc Respectfully submitted,

John F. Hayden

Reg. No. 37,640

Sheet	1	of	1
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Substitute Disclosure Form (PTO-1449)

(Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-289001	Application No. 10/006,043	
	closure Statement	Applicant Satoshi Murakami, et	al.	
(Use several sh	neets if necessary)	Filing Date December 4, 2001	Group Art Unit 2814	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
,	AA	6,306,694 B1	10/23/2001	Yamazaki et al.			03/10/2000
	AB	6,737,304 B2	05/18/2004	Yamazaki et al.			10/10/2001
	AC	2002/0028543 A1	03/07/2002	Yamazaki et al.			10/10/2001
	AD	2004/0197971 A1	10/07/2004	Yamazaki et al.			04/26/2004
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

	Foreign Patent Documents or Published Foreign Patent Applications							
Examiner	Desig.	Document	Publication	Country or			Trans	slation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL	2000-332256	11/30/2000	JAPAN			AB	
	AM							
	AN							
	AO							
	AP							

	Other Documents (include Author, Title, Date, and Place of Publication)					
Examiner	Desig.					
Initial	ID	Document				
	AQ					
	AR					
	AS					
	AT					

Examiner Signature	Date Considered				
Examinor orginators	53.5 00.6.6.0.0				
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with					
next communication to applicant.					